

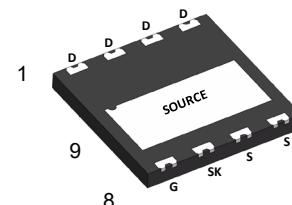
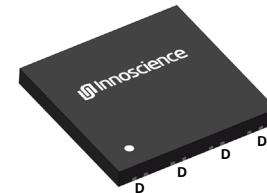
INN650D150A

1. General description

650V GaN-on-Silicon Enhancement-mode Power Transistor in Dual Flat No-lead package (DFN) with 8 mm × 8 mm size

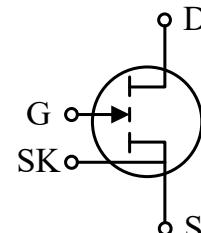
2. Features

- Enhancement mode transistor-Normally off power switch
- Ultra high switching frequency
- No reverse-recovery charge
- Low gate charge, low output charge
- Qualified for industrial applications according to JEDEC Standards
- ESD safeguard
- RoHS, Pb-free, REACH-compliant



3. Applications

- AC-DC converters
- DC-DC converters
- Totem pole PFC
- Fast battery charging
- High density power conversion
- High efficiency power conversion



4. Key performance parameters

Table 1 Key performance parameters at $T_j = 25^\circ\text{C}$

Parameter	Value	Unit
$V_{DS,\text{max}}$	650	V
$R_{DS(\text{on}),\text{max}} @ V_{GS} = 6 \text{ V}$	150	mΩ
$Q_{G,\text{typ}} @ V_{DS} = 400 \text{ V}$	3	nC
$I_{D,\text{pulse}}$	32	A
$Q_{oss} @ V_{DS} = 400 \text{ V}$	28	nC
$Q_{rr} @ V_{DS} = 400 \text{ V}$	0	nC

5. Pin information

Table 2 Pin information

Gate	Drain	Kelvin Source	Source
8	1,2,3,4	7	5,6,9

Table 3 Ordering information

Type/Ordering Code	Package	Product Code
INN650D150A	DFN 8X8	65D150A

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6. Maximum ratings

at $T_j = 25^\circ\text{C}$ unless otherwise specified.

Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact Innosience sales office.

Table 4 Maximum ratings

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain source voltage	$V_{DS,\max}$	-	-	650	V	$V_{GS} = 0 \text{ V}$, $T_j = -55^\circ\text{C}$ to 150°C
Drain source voltage transient ¹	$V_{DS(\text{transient})}$	-	-	800	V	$V_{GS} = 0 \text{ V}$, $V_{DS} = 800 \text{ V}$
Drain source voltage, pulsed ²	$V_{DS,\text{surge}}$			750	V	$T_j = 25^\circ\text{C}$; total time < 10h
Drain source voltage, pulsed ²	$V_{DS,\text{surge}}$			750	V	$T_j = 125^\circ\text{C}$; total time < 1h
Continuous current, drain source	I_D	-	-	17	A	$T_c = 25^\circ\text{C}$
Pulsed current, drain source ³	$I_{D,\text{pulse}}$	-	-	32	A	$T_c = 25^\circ\text{C}$; $V_G = 6 \text{ V}$; See Figure 16
Pulsed current, drain source ³	$I_{D,\text{pulse}}$	-	-	23	A	$T_c = 125^\circ\text{C}$; $V_G = 6 \text{ V}$; See Figure 17
Gate source voltage, continuous ⁴	V_{GS}	-1.4	-	+7	V	$T_j = -55^\circ\text{C}$ to 150°C
Gate source voltage, pulsed	$V_{GS,\text{pulse}}$	-20	-	+10	V	$T_j = -55^\circ\text{C}$ to 150°C ; $t_{PULSE} = 50 \text{ ns}$, $f = 100 \text{ kHz}$ open drain
Power dissipation	P_{tot}	-	-	113	W	$T_c = 25^\circ\text{C}$
Operating temperature	T_j	-55	-	+150	°C	
Storage temperature	T_{stg}	-55	-	+150	°C	

1 $V_{DS(\text{transient})}$ is intended for surge rating during non-repetitive events, $t_{PULSE} < 200 \mu\text{s}$

2 $V_{DS,\text{surge}}$ is intended for surge rating during repetitive pulse, $t_{PULSE} < 100 \text{ ns}$

3 Pulse = 300 μs

4 The minimum V_{GS} is clamped by ESD protection circuit, as shown in Figure 10

7. Thermal characteristics

Table 5 Thermal characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction-case	R _{thJC}	-	-	1.1	°C/W	
Reflow soldering temperature	T _{sold}	-	-	260	°C	MSL3

8. Electric characteristics

at $T_j = 25^\circ\text{C}$, unless specified otherwise

Table 6 Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate threshold voltage	$V_{GS(\text{th})}$	1.2	1.6	2.2	V	$I_D = 17.2 \text{ mA}; V_{DS} = V_{GS}; T_j = 25^\circ\text{C}$
		-	1.5	-		$I_D = 17.2 \text{ mA}; V_{DS} = V_{GS}; T_j = 150^\circ\text{C}$
Drain-source leakage current	I_{DSS}	-	0.7	25	μA	$V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$
		-	6	200		$V_{DS} = 650 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150^\circ\text{C}$
Gate-source leakage current	I_{GSS}	-	30	-	μA	$V_{GS} = 6 \text{ V}; V_{DS} = 0 \text{ V}$
Drain-source on-state resistance	$R_{DS(\text{on})}$	-	115	150	$\text{m}\Omega$	$V_{GS} = 6 \text{ V}; I_D = 5 \text{ A}; T_j = 25^\circ\text{C}$
		-	234	-	$\text{m}\Omega$	$V_{GS} = 6 \text{ V}; I_D = 5 \text{ A}; T_j = 150^\circ\text{C}$
Gate resistance	R_G	-	1.4	-	Ω	$f = 5 \text{ MHz}; \text{open drain}$

Table 7 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	110	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$
Output capacitance	C_{oss}	-	30	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$
Reverse transfer capacitance	C_{rss}	-	0.46	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V}; f = 100 \text{ kHz}$
Effective output capacitance, energy related ¹	$C_{o(er)}$	-	42	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$
Effective output capacitance, time related ²	$C_{o(tr)}$	-	68	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$
Output charge	Q_{oss}	-	28	-	nC	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V}$
Turn-on delay time	$t_{d(on)}$	-	3	-	nS	See Figure 22
Turn-off delay time	$t_{d(off)}$	-	7	-	nS	See Figure 22
Rise time	t_r	-	5	-	nS	See Figure 22
Fall time	t_f	-	5	-	nS	See Figure 22

1 $C_{o(er)}$ is the fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400 V

2 $C_{o(tr)}$ is the fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400 V

Table 8 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Gate charge	Q _G	-	3	-	nC	V _{GS} = 0 to 6 V; V _{DS} = 400 V; I _D = 5 A
Gate-source charge	Q _{GS}	-	0.28	-	nC	
Gate-drain charge	Q _{GD}	-	1.63	-	nC	
Gate Plateau Voltage	V _{Plat}	-	2.3	-	V	

Table 9 Reverse conduction characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Source-Drain reverse voltage	V _{SD}	-	2.6	-	V	V _{GS} = 0 V; I _S = 5 A
Pulsed current, reverse	I _{S,pulse}	-	-	32	A	V _{GS} = 6 V
Reverse recovery charge	Q _{rr}	-	0	-	nC	I _{SD} = 5 A; V _{DS} = 400 V
Reverse recovery time	t _{rr}	-	0	-	ns	
Peak reverse recovery current	I _{rrm}	-	0	-	A	

9. Electric characteristics diagrams

at $T_j = 25^\circ\text{C}$, unless specified otherwise

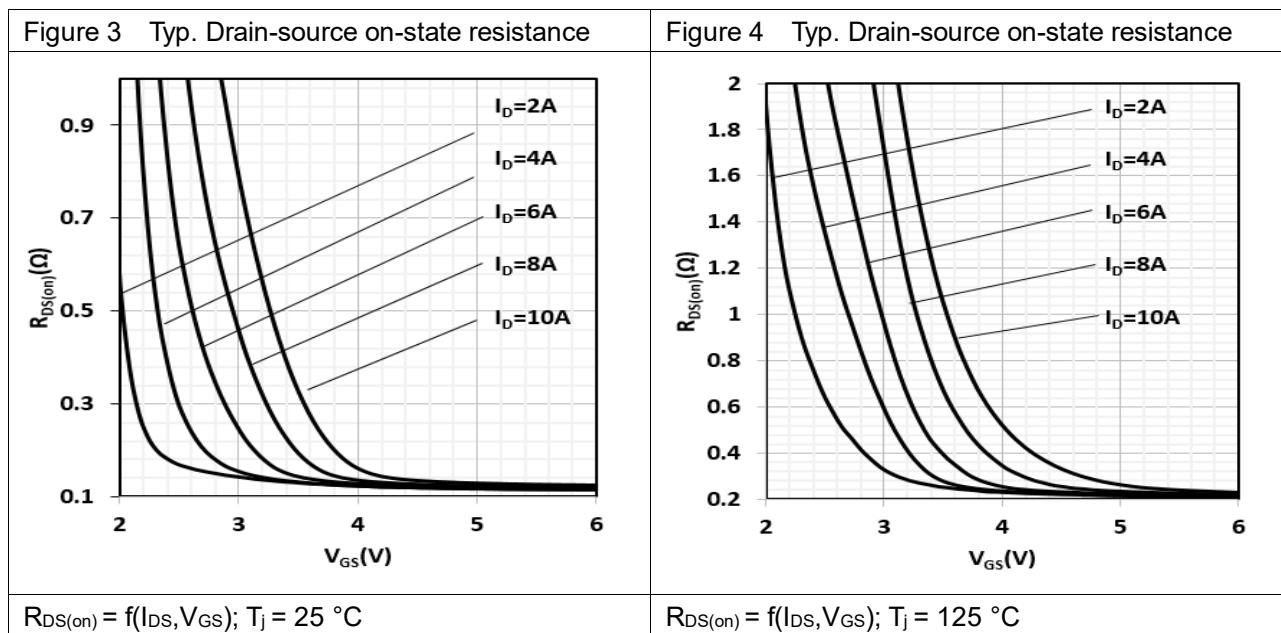
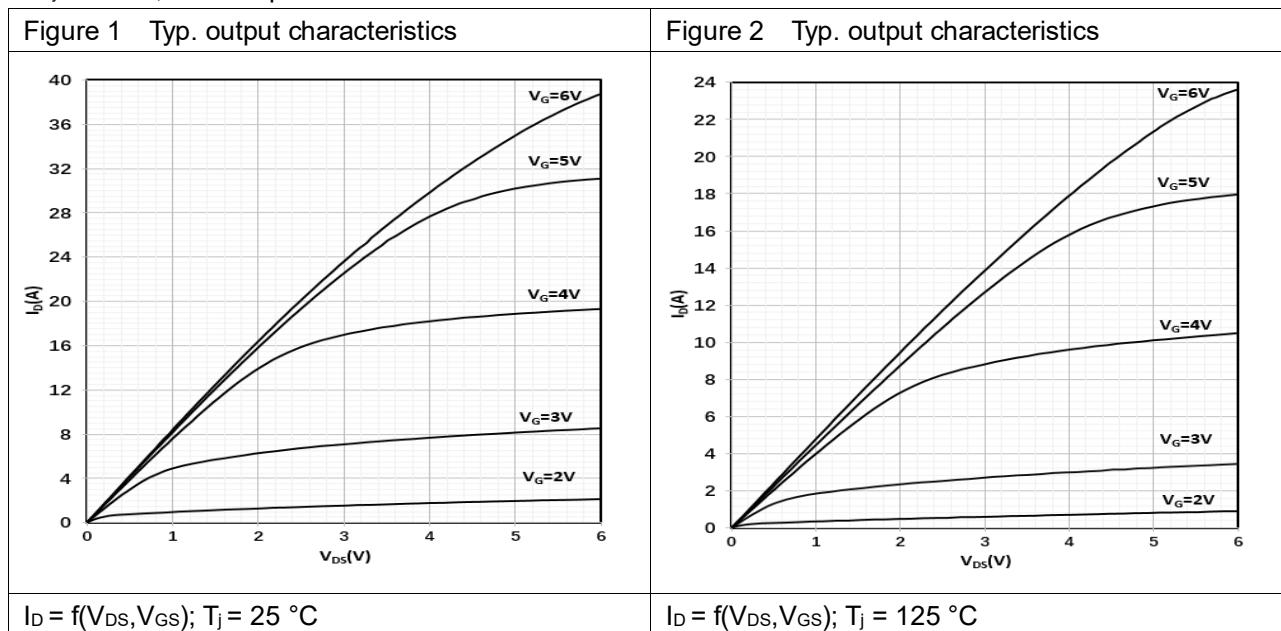


Figure 5 Typ. channel reverse characteristics

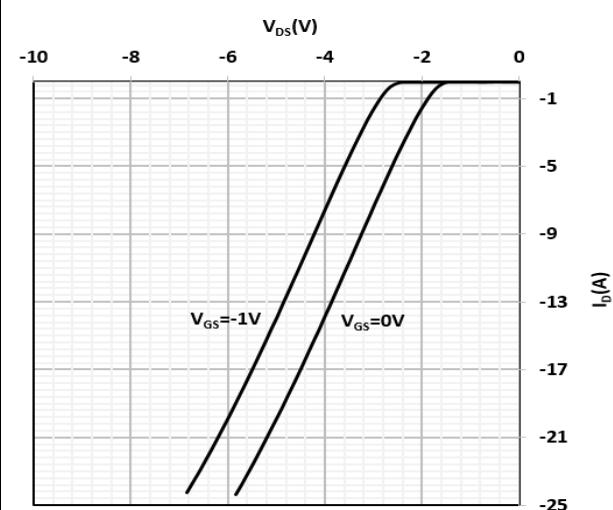
 $I_D = f(V_{DS}, V_{GS})$; $T_j = 25\text{ }^\circ\text{C}$

Figure 6 Typ. channel reverse characteristics

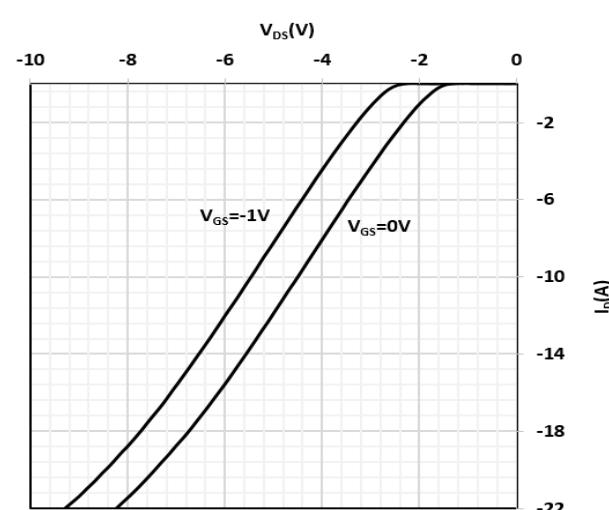
 $I_D = f(V_{DS}, V_{GS})$; $T_j = 125\text{ }^\circ\text{C}$

Figure 7 Typ. channel reverse characteristics

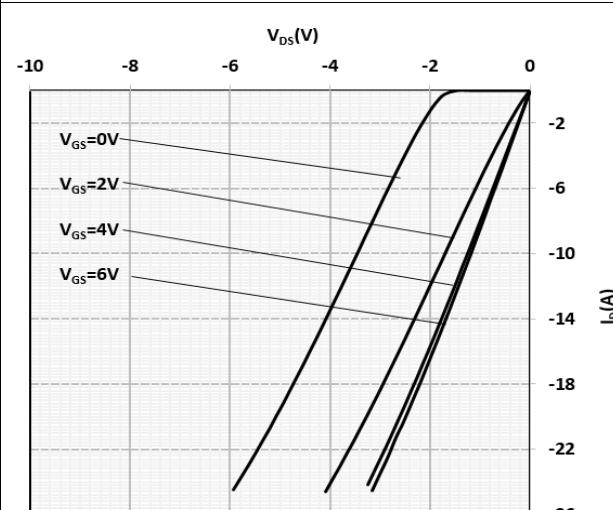
 $I_D = f(V_{DS}, V_{GS})$; $T_j = 25\text{ }^\circ\text{C}$

Figure 8 Typ. channel reverse characteristics

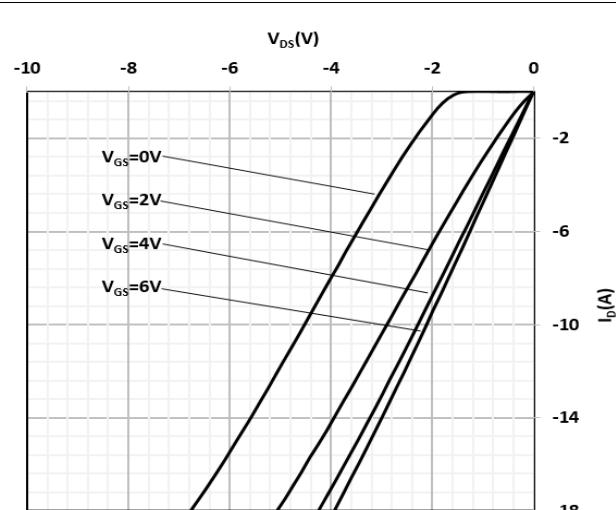
 $I_D = f(V_{DS}, V_{GS})$; $T_j = 125\text{ }^\circ\text{C}$

Figure 9 Typ. transfer characteristics

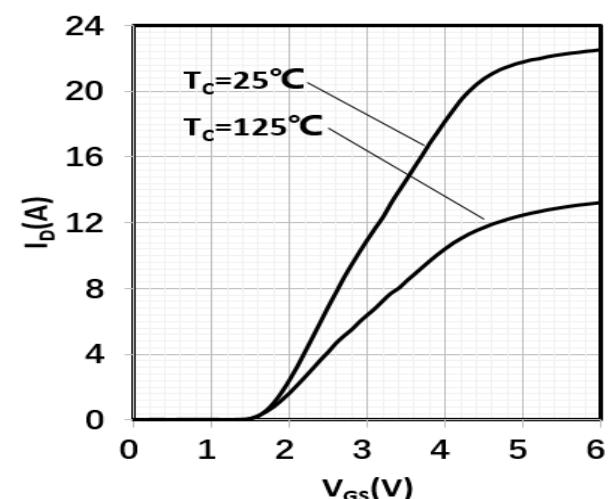
 $I_D = f(V_{GS})$; $V_{DS} = 3\text{ V}$

Figure 10 Typ. Gate-to-Source leakage

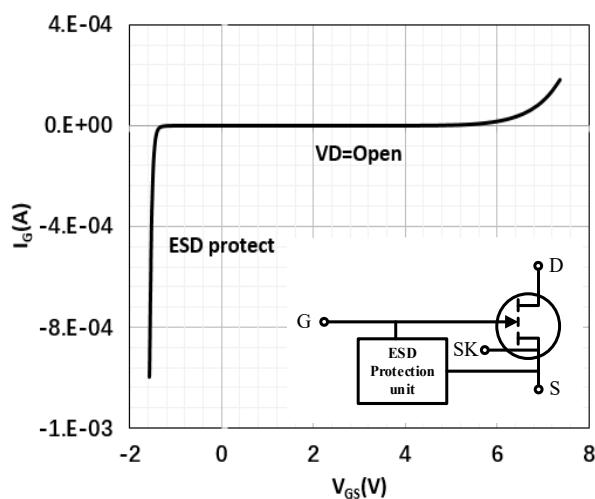
 $I_G = f(V_{GS})$; I_G reverse turn on by ESD unit

Figure 11 Drain-source leakage characteristics

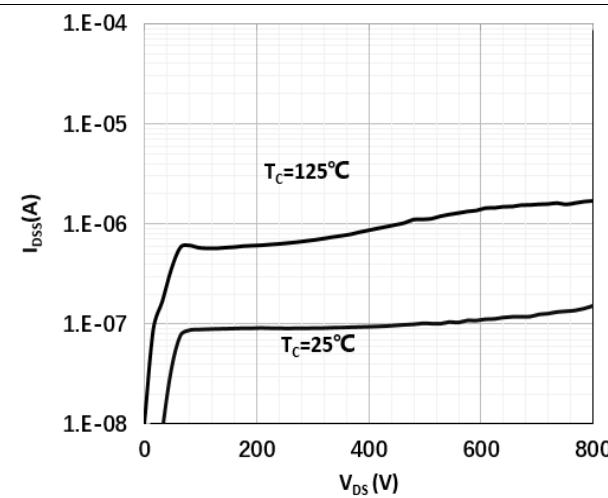
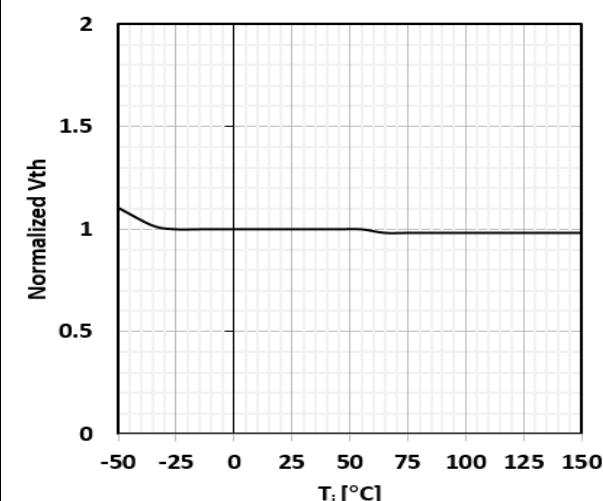
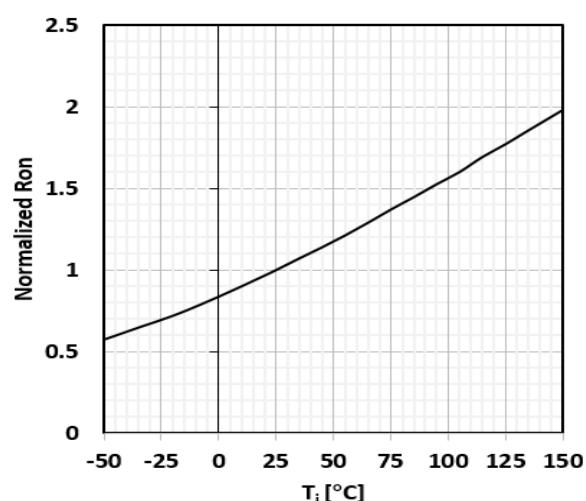
 $I_{DSS} = f(V_{DS})$; $V_{GS} = 0\text{ V}$

Figure 12 Gate threshold voltage



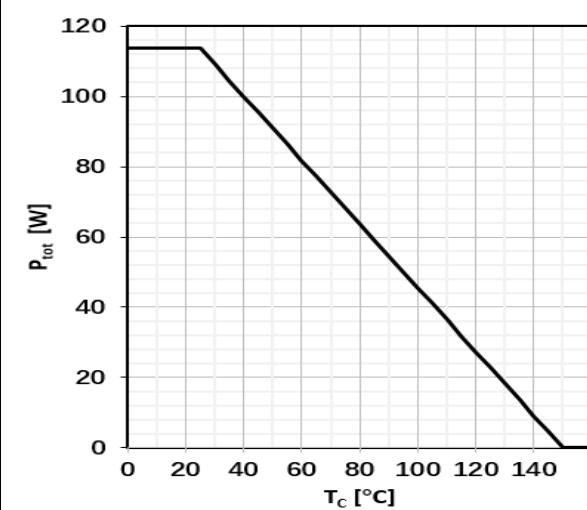
$$V_{TH} = f(T_j); V_{GS} = V_{DS}; I_D = 17.2 \text{ mA}$$

Figure 13 Drain-source on-state resistance



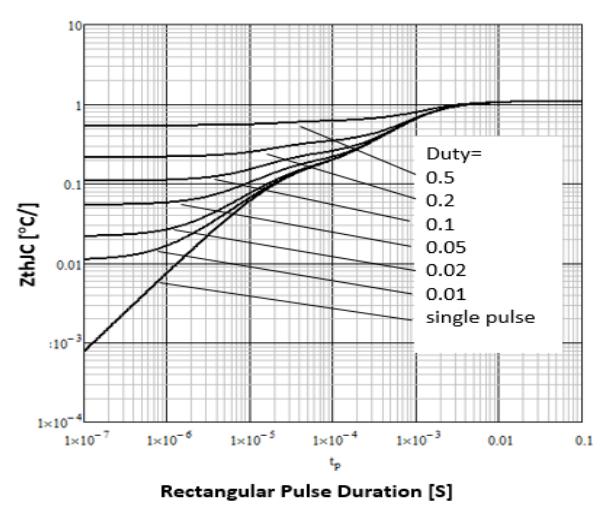
$$R_{DS(on)} = f(T_j); I_D = 5 \text{ A}; V_G = 6 \text{ V}$$

Figure 14 Power dissipation



$$P_{tot} = f(T_c)$$

Figure 15 Max.transient thermal impedance



$$Z_{thJC} = f(t_p, D)$$

Figure 16 Safe operating area

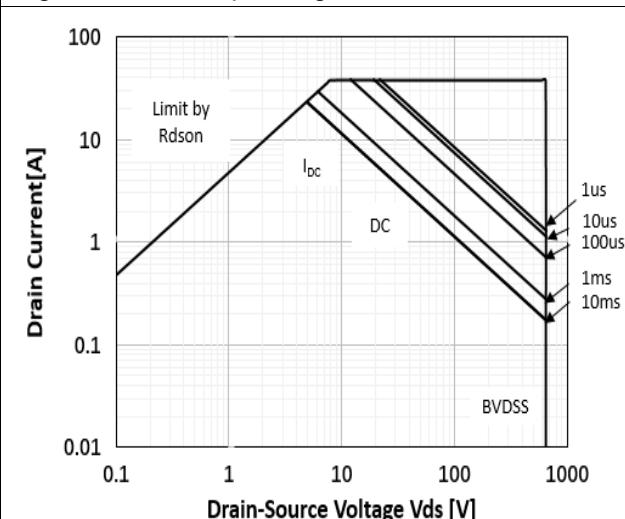
 $I_D = f(V_{DS})$; $T_C = 25 \text{ } ^\circ\text{C}$

Figure 17 Safe operating area

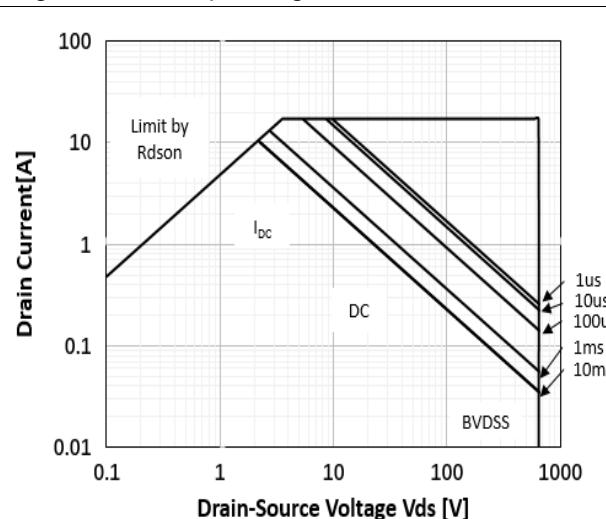
 $I_D = f(V_{DS})$; $T_C = 125 \text{ } ^\circ\text{C}$

Figure 18 Typ. gate charge

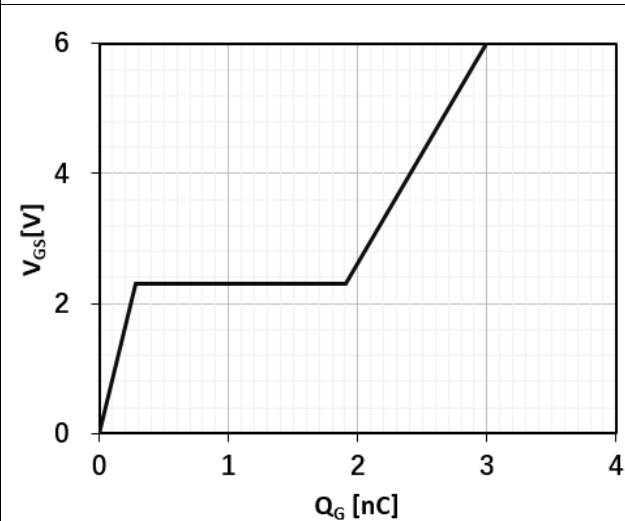
 $V_{GS} = f(Q_G)$; $V_{DCLINK} = 400 \text{ V}$; $I_D = 5 \text{ A}$

Figure 19 Typ. capacitances

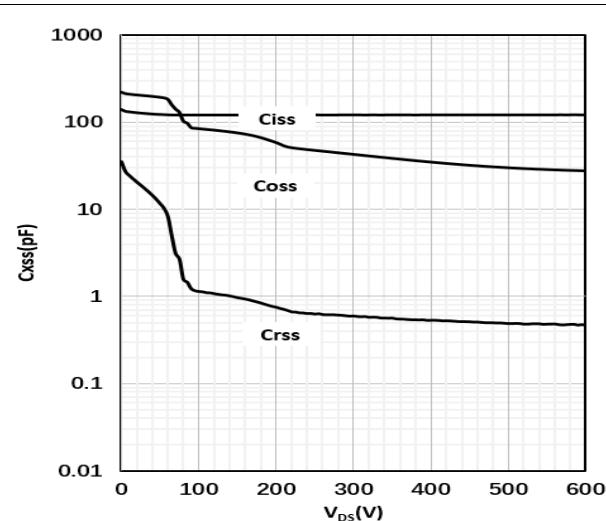
 $C_{XSS} = f(V_{DS})$; Freq. = 100 kHz

Figure 20 Typ. output charge

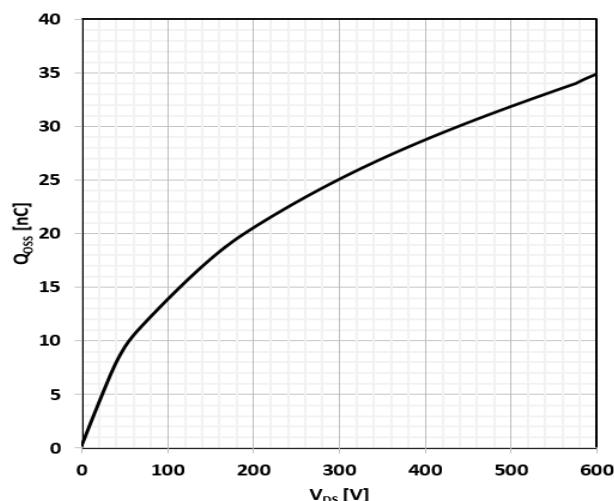
Q_{oss} = f(V_{DS}); Freq. = 100 kHz

Figure 21 Typ. Coss stored Energy

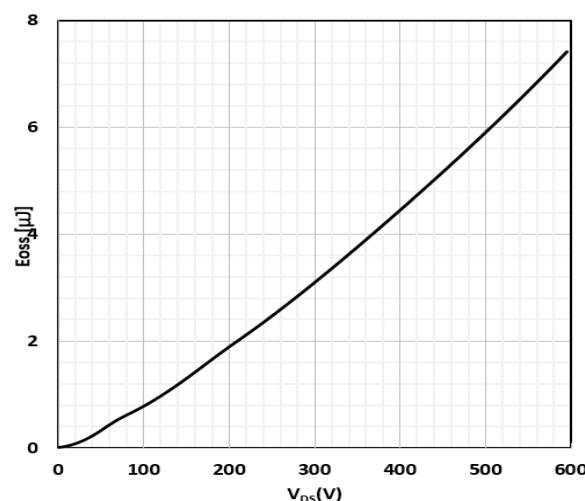
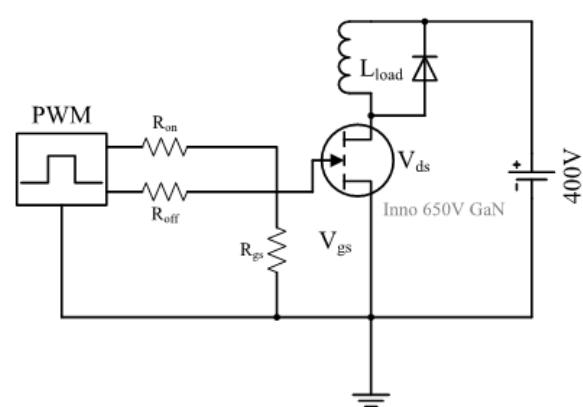
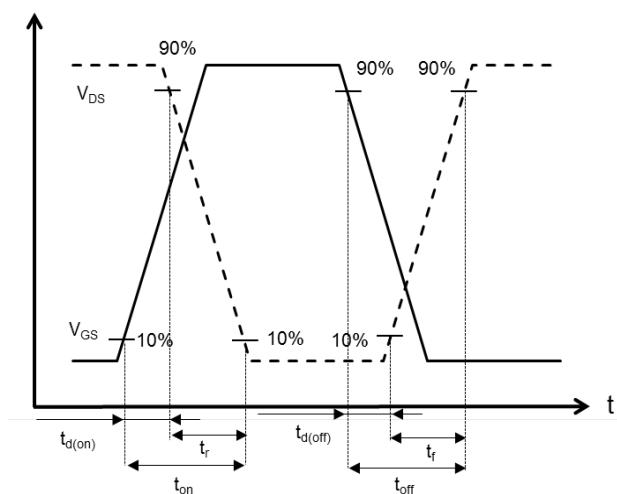
E_{oss} = f(V_{DS}); Freq. = 100 kHz

Figure 22 Typ.Switching times with inductive load

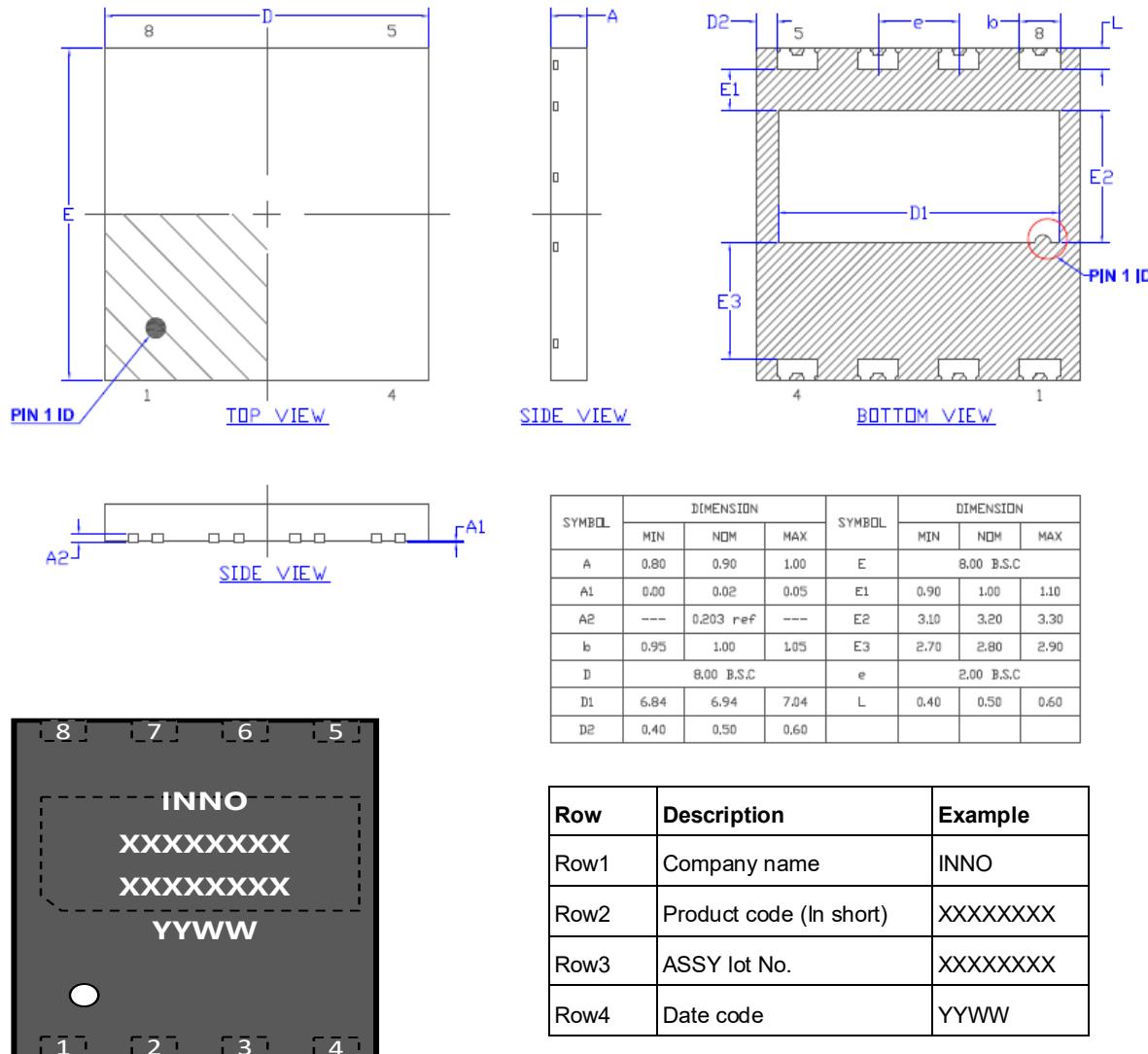


$V_{DS}=400V$, $I_D=5A$, $L_{load}=800\mu H$, $V_{GS}=6V$, $R_{on}=10\Omega$,
 $R_{off}=2\Omega$, $R_{gs}=10k\Omega$

Figure 23 Typ.Switching times waveform



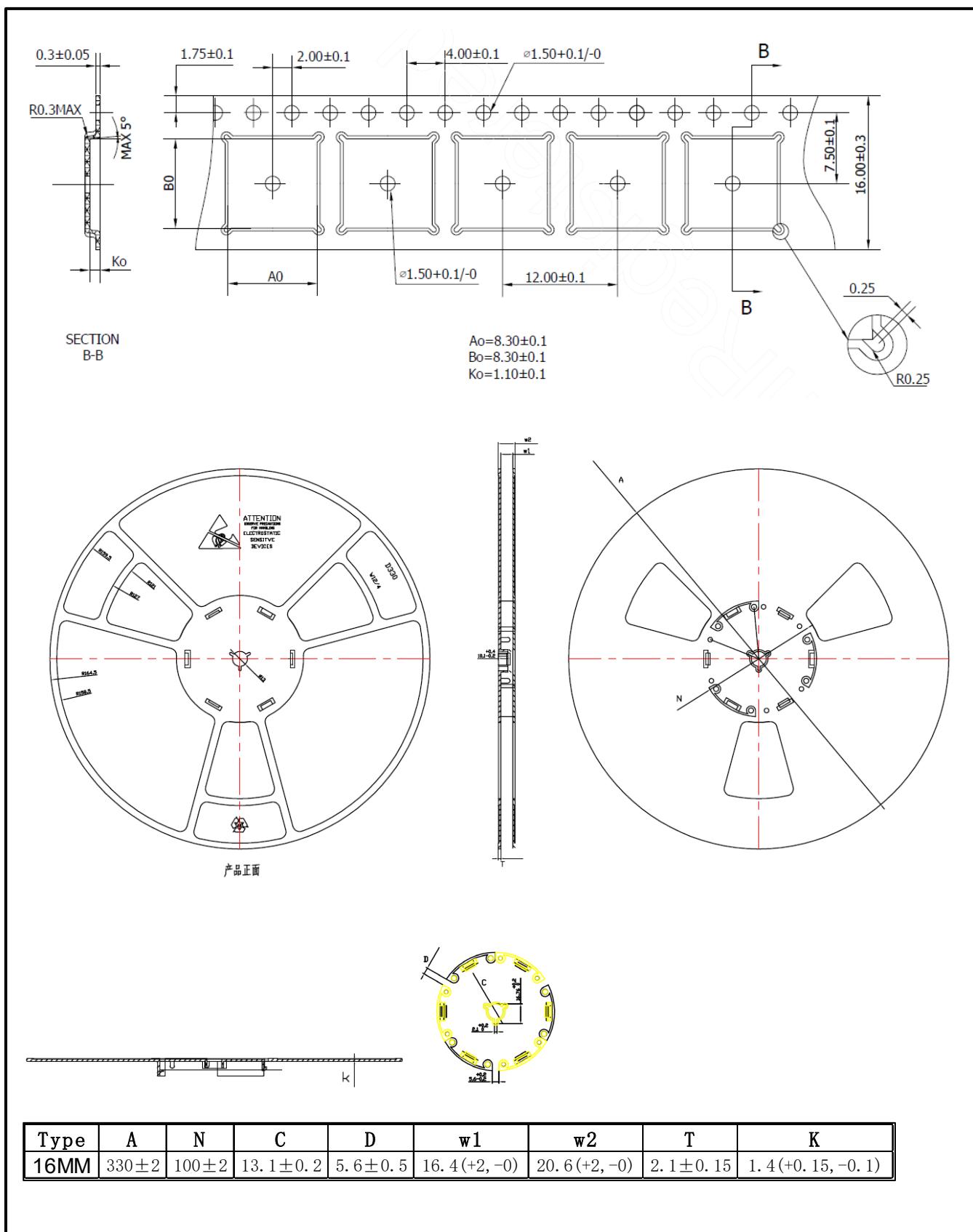
10. Package outlines



Notes:

- (1) Dimension and tolerance conform to ASME Y14.5-2009.
- (2) All dimension are in millimeters.
- (3) Lead coplanarity shall be 0.1 millimeters max.
- (4) Complies with JEDEC MO-229.
- (5) Drawing is not to scale.

11. Reel Information



12. Revision history

Major changes since the last revision

Revision	Date	Description of changes
1.0	2021-4-23	1.0 version release

Important Notice

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